

Docket No.: P2001,0097

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : DETLEV RICHTER
Filed : CONCURRENTLY HEREWITH
Title : SEMICONDUCTOR MODULE WITH A CONFIGURATION FOR THE
SELF-TEST OF A PLURALITY OF INTERFACE CIRCUITS AND TEST
METHOD



INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner of Patents and Trademarks,
Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

German Published Non-Prosecuted Patent Application DE 198 32 307 A1 (Schaffroth et al.), dated February 3, 2000, integrated circuit with self-testing device;

German Patent Application DE 199 01 460 C1 (Daehn), dated August 31, 2000, integrated circuit and procedure for functional testing of bond pad cells;

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "Wm Stemer", written over a horizontal line.

For Applicant

WERNER H. STEMER
REG. NO. 34,956

Date: February 13, 2002

Lerner and Greenberg, P.A.
Post Office Box 2480
Hollywood, FL 33022-2480
Tel: (954) 925-1100
Fax: (954) 925-1101

/kf

FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: P2001,0097 Appl. No. Applicant DETLEV RICHTER Filing Date February 13, 2002 Group Art Unit			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	198 32 307 A1	2/3/00	Germany			
	K	199 01 460 C1	8/31/00	Germany			
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

 31000 U.S. PTO
 10/075656
 02/13/02
